



WANSEMI
万芯半导体

WP4614

Enhancement Mode N+P-Channel Power MOSFET

SOP8/N+PMOS/40V/ $\pm 20V$ /1.5V/8A/15m Ω

-40V/ $\pm 20V$ /-1.5V/-7A/33m Ω

Rev0.4

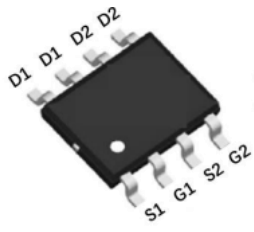
40V N+P-Channel MOSFET

1.Features

- ◆ High power and current handling capability
- ◆ Lead free product is acquired
- ◆ Fast switching
- ◆ Surface mount package

2.Applications

- ◆ Power Switching Application
- ◆ Load Switching



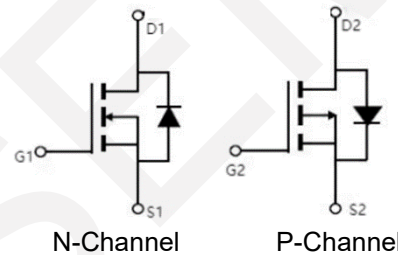
SOP8
Pin Description

◆ N-Channel

V_{DS}	$R_{DS(on)}$ Typ.	I_D
40V	15m Ω @ 10V	8A
	20m Ω @ 4.5V	

◆ P-Channel

V_{DS}	$R_{DS(on)}$ Typ.	I_D
-40V	33m Ω @ -10V	-7A
	42m Ω @ -4.5V	



Schematic Diagram

3.Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP4614	4614	SOP8	4,000	48,000

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	N-channel	P-channel	Units	
Drain to Source Voltage	V_{DSS}	40	-40	V	
Gate to Source Voltage	V_{GSS}	± 20	± 20	V	
Drain Current (DC),	TA=25 °C	I_D	8	-7	A
	TA=100 °C	I_D	5.2	-3.9	A
Drain Current (Pulse), PW \leq 300 μ s	I_{DM}	40	-30	A	
Total Dissipation	P_D	2.0	2.0	W	
Junction Temperature	T_j	150	150	°C	
Storage Temperature	T_{stg}	-55 to +150	-55 to +150	°C	

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Maximum Junction-to-Ambient	$R_{\theta JA}$	62.5	$^{\circ}C/W$

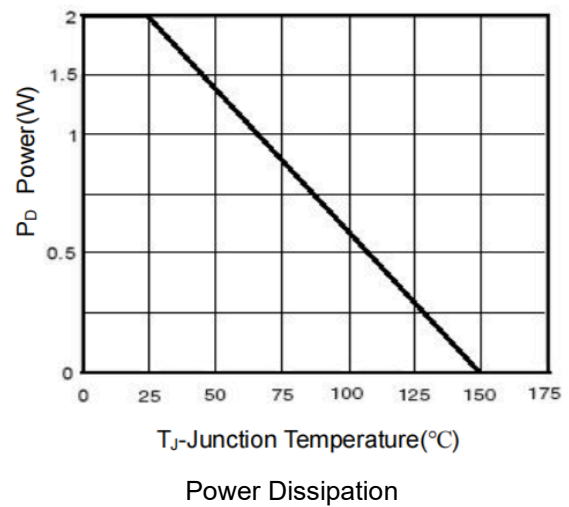
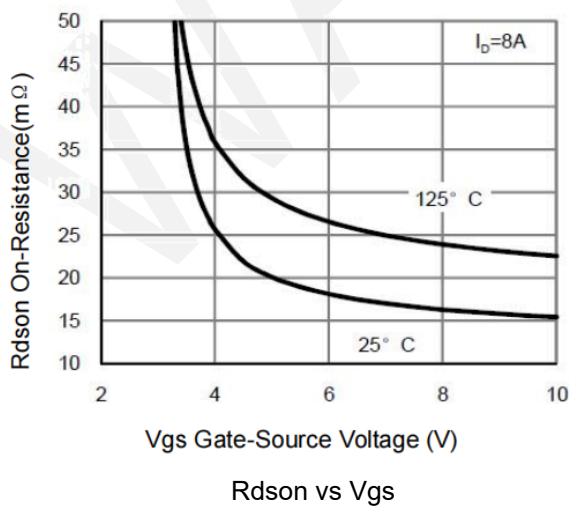
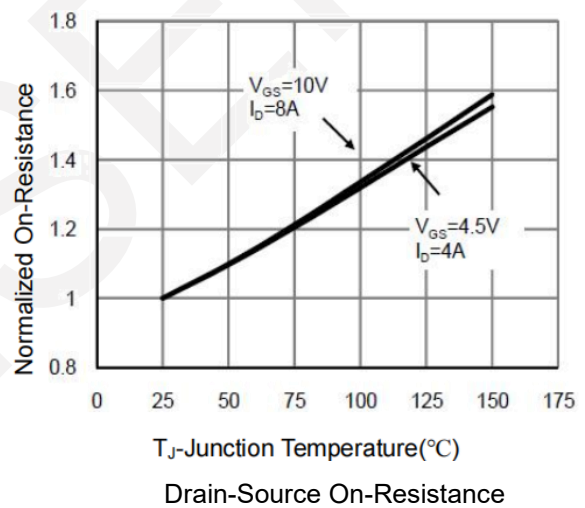
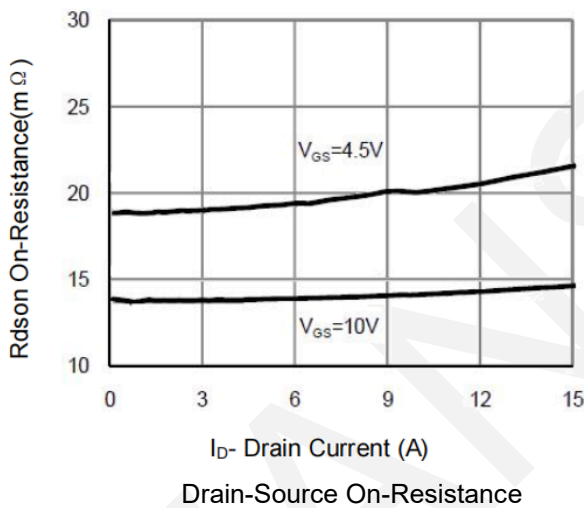
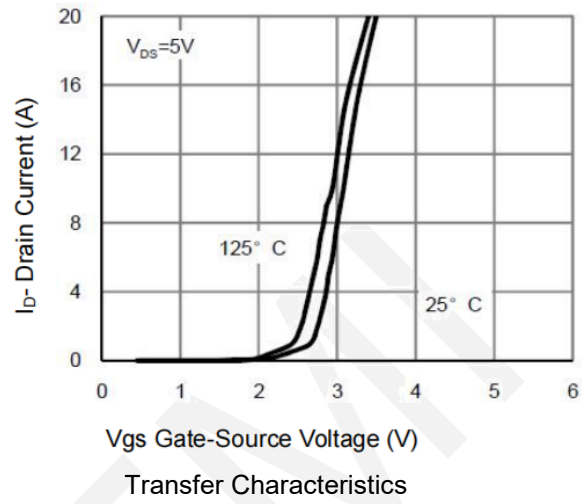
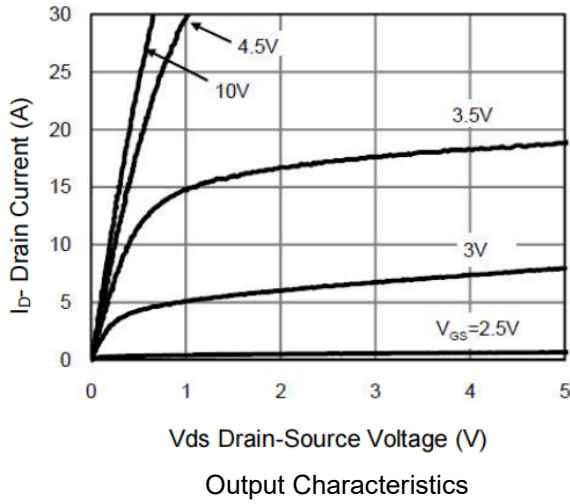
Note 2: When mounted on 1 inch square copper board $t \leq 10$ sec The value in any given application depends on the user's specific board design.

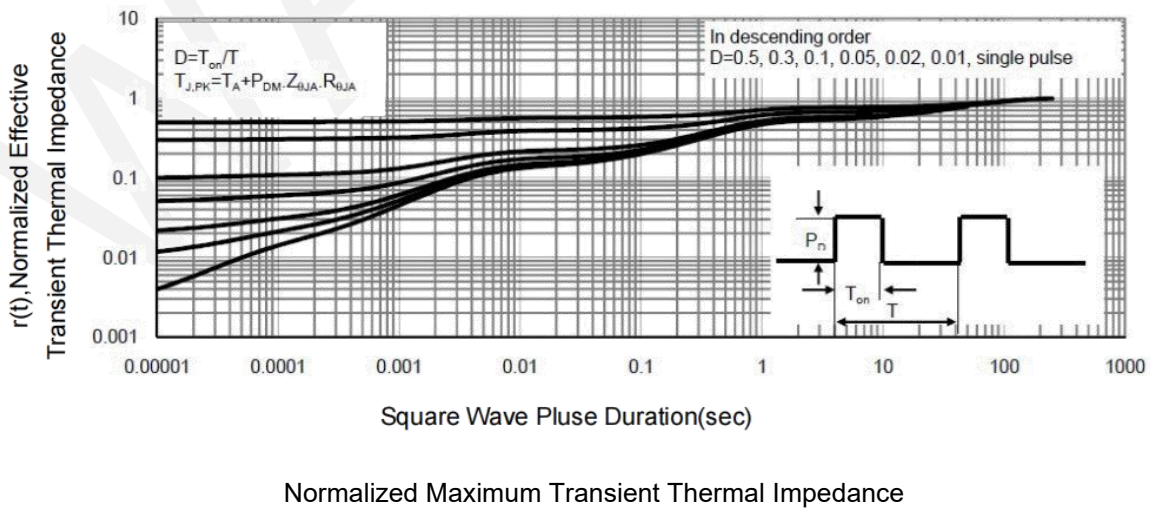
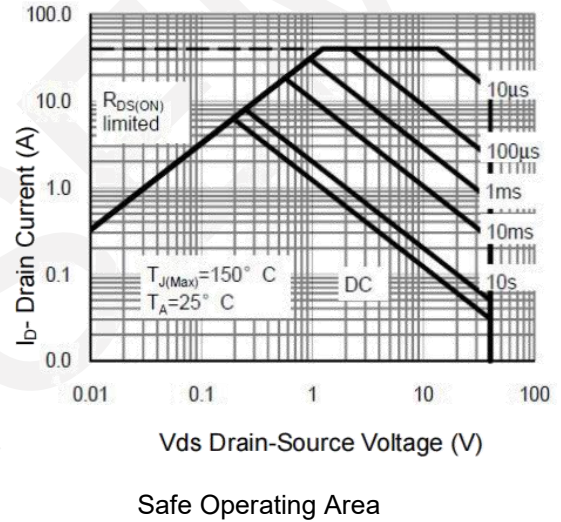
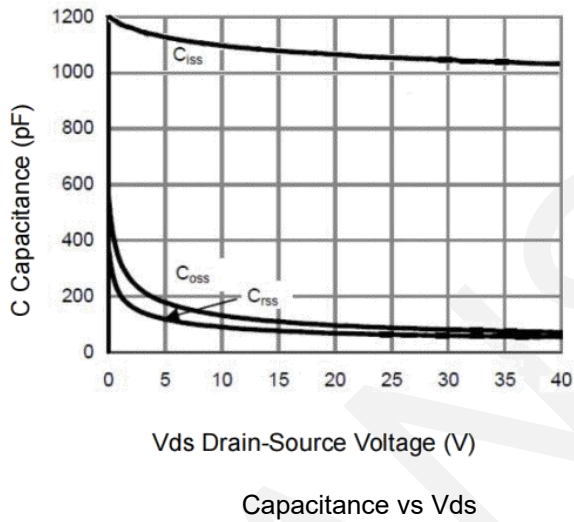
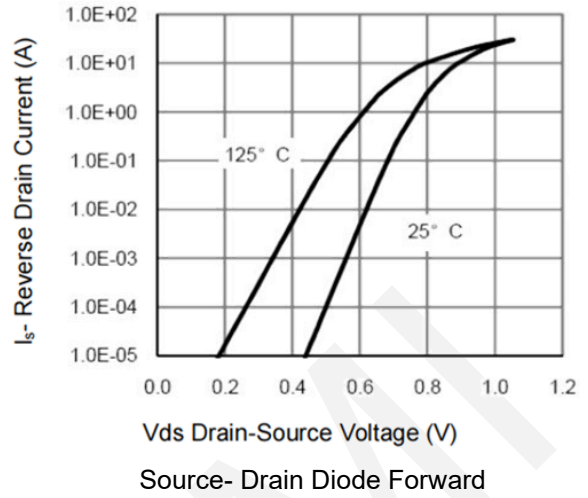
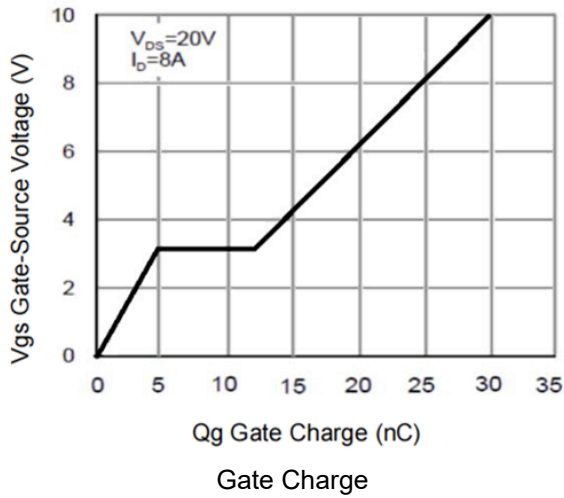
6. NMOS Electrical Characteristics at $T_a=25^{\circ}C$ (Note 3)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	$I_D = 250\mu A, V_{GS} = 0V$	40	-	-	V
Zero-Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 40V, V_{GS} = 0V$	-	-	1	μA
Gate to Source Leakage Current	I_{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	± 100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_{DS}=250\mu A$	1.0	1.5	2.5	V
Static Drain to Source On-State Resistance	$R_{DS(on)}$	$I_D = 8A, V_{GS} = 10V$	-	15	20	$m\Omega$
		$I_D = 4A, V_{GS} = 4.5V$	-	20	30	$m\Omega$
Input Capacitance	C_{iss}	$V_{GS}=0V,$ $V_{DS}=20V,$ Frequency=1.0MHz	-	1110	-	pF
Output Capacitance	C_{oss}		-	114	-	pF
Reverse Transfer Capacitance	C_{rss}		-	109	-	pF
Turn-ON Delay Time	$t_{d(on)}$	$V_{DD} = 20V$ $V_{GS} = 10V$ $R_{GEN} = 2.5\Omega$ $I_D = 8A$	-	5.5	-	ns
Rise Time	t_r		-	14	-	ns
Turn-OFF Delay Time	$t_{d(off)}$		-	24	-	ns
Fall Time	t_f		-	12	-	ns
Total Gate Charge	Q_g	$V_{DS} = 20V,$ $V_{GS} = 10V,$ $I_D = 8A$	-	30	-	nC
	Q_{gs}		-	5	-	nC
	Q_{gd}		-	7	-	nC
Diode Forward Voltage	V_{FSD}	$I_S = 8A, V_{GS} = 0V$	-	-	1.2	V



NMOS Typical electrical and thermal characteristics





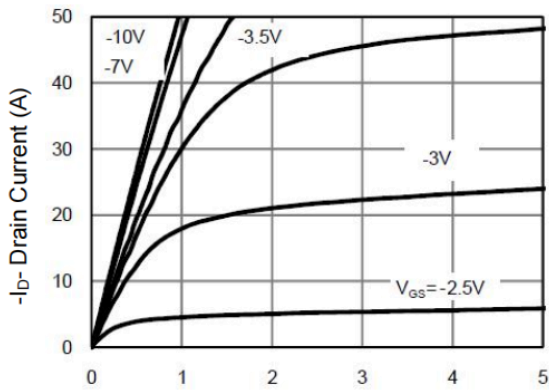
7.PMOS Electrical Characteristics at Ta=25°C

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	$I_D = -250\mu A, V_{GS} = 0V$	-40			V
Zero-Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -40V, V_{GS} = 0V$			-1	μA
Gate to Source Leakage Current	I_{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$			± 100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_{DS}=-250\mu A$	-1.0	-1.5	-2.5	V
Static Drain to Source On-State Resistance	$R_{DS(on)}$	$I_D = -7A, V_{GS} = -10V$		33	49	m Ω
		$I_D = -4A, V_{GS} = -4.5V$		42	66	m Ω
Input Capacitance	C_{iss}	$V_{GS}=0V,$ $V_{DS}=-20V,$ Frequency=1.0MHz		1139	-	pF
Output Capacitance	C_{oss}			114	-	pF
Reverse Transfer Capacitance	C_{rss}			103	-	pF
Turn-ON Delay Time	$t_{d(on)}$			7.5	-	ns
Rise Time	t_r	$V_{DD} = -20V$ $V_{GS} = -10V$		5.5	-	ns
Turn-OFF Delay Time	$t_{d(off)}$	$R_{GEN} = 6\Omega,$ $R_L = 2.9\Omega,$		19	-	ns
Fall Time	t_f			7	-	ns
Total Gate Charge	Q_g	$V_{DS} = -20V,$ $V_{GS} = -10V,$ $I_D = -7A$		22.5		nC
	Q_{gs}			2.4		nC
	Q_{gd}			5.1		nC
Diode Forward Voltage	V_{FSD}	$I_S = -7A, V_{GS} = 0V$			-1.2	V

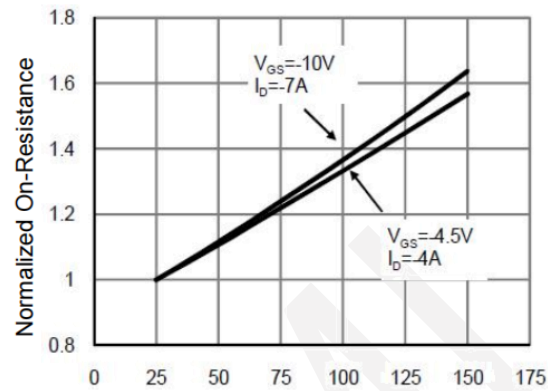
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



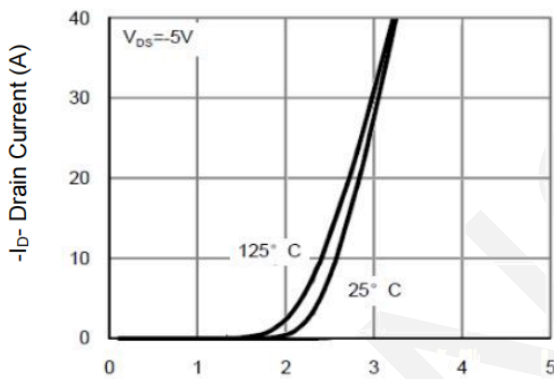
PMOS Typical electrical and thermal characteristics



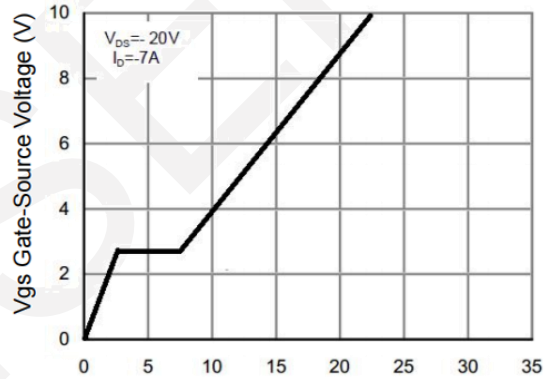
-V_{DS} Drain-Source Voltage (V)
Output Characteristics



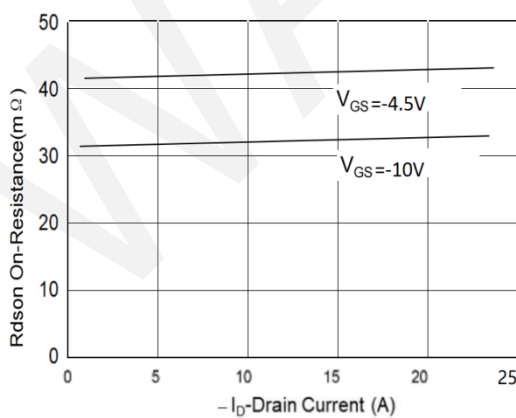
T_J -Junction Temperature(°C)
R_{dson}-Junction Temperature



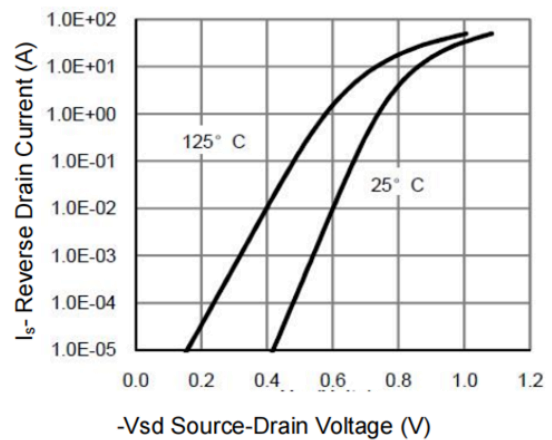
-V_{GS} Gate-Source Voltage (V)
Transfer Characteristics



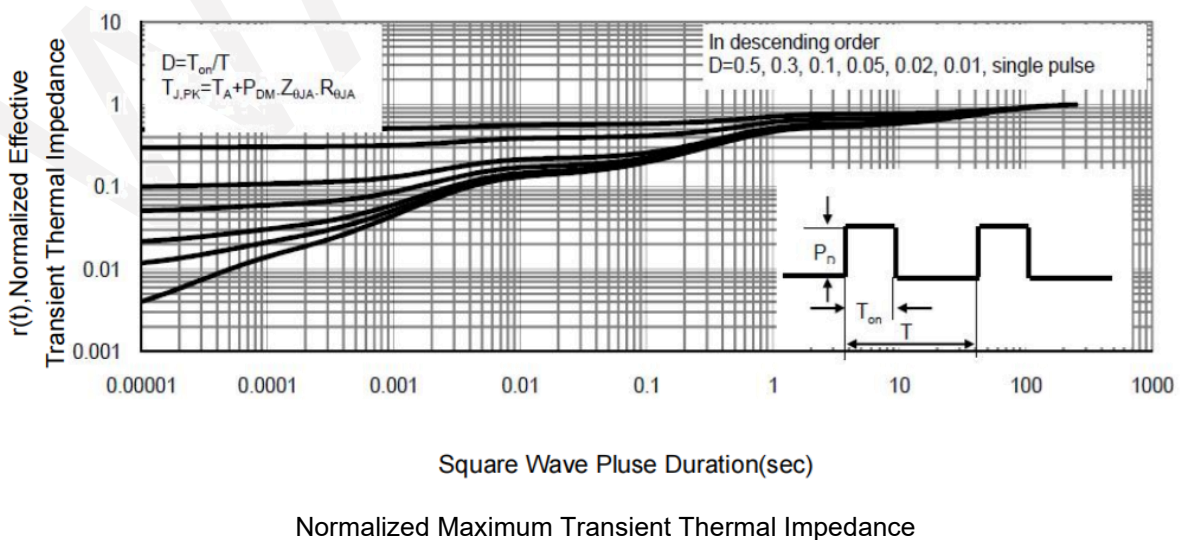
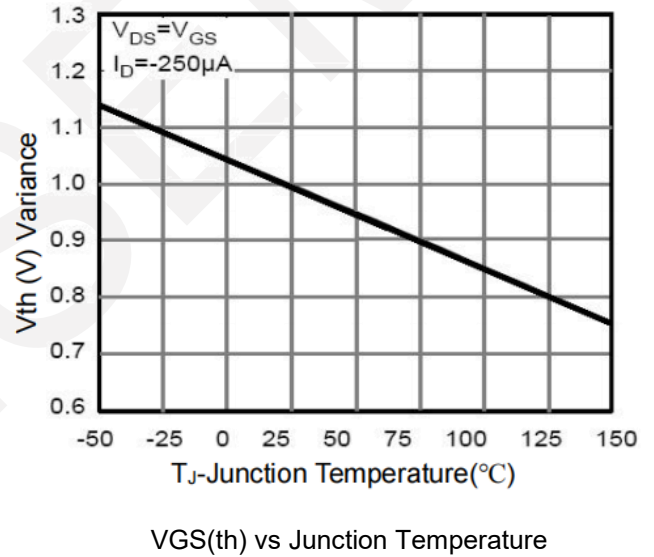
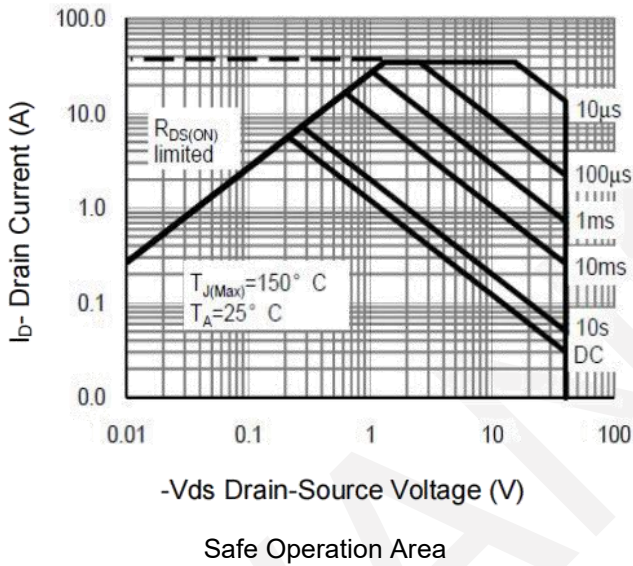
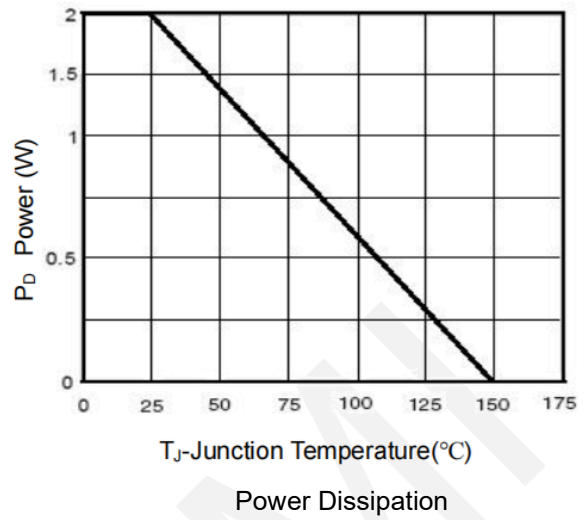
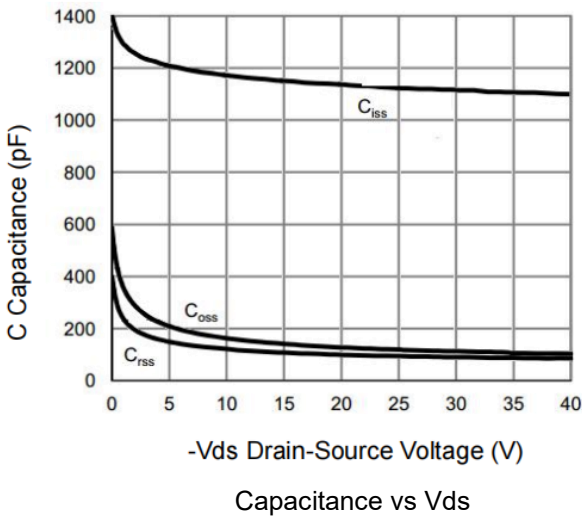
Q_g Gate Charge (nC)
Gate Charge



R_{dson}- Drain Current

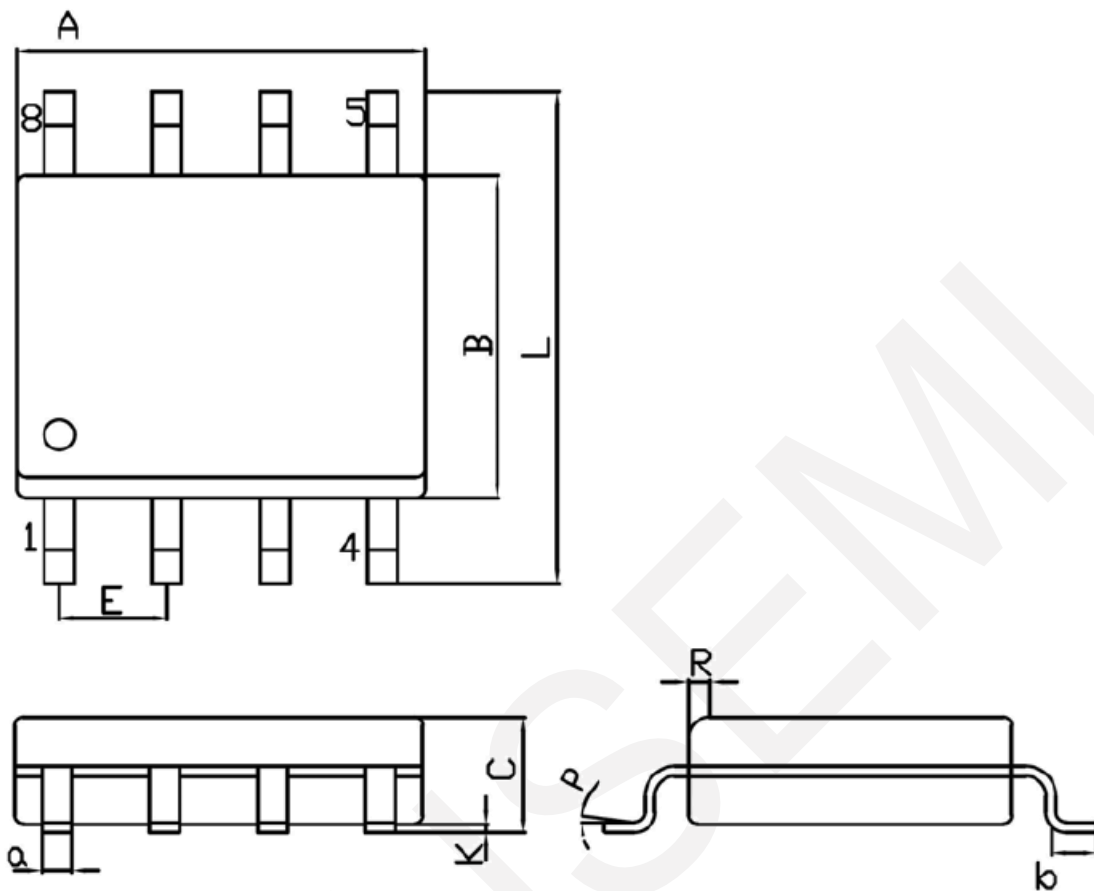


Source- Drain Diode Forward





8.Package Dimensions



Symbol	Dimensions In Millimeters		Symbol	Dimensions In Millimeters	
	Min	Max		Min	Max
A	4.70	5.10	C	1.35	1.75
B	3.70	4.10	a	0.35	0.49
L	5.80	6.20	R	0.30	0.60
E	1.27BSC		P	0°	7°
K	0.12	0.22	b	0.40	1.25

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